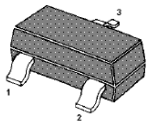
MMBT3906

PNP TRANSISTOR

FEATURES

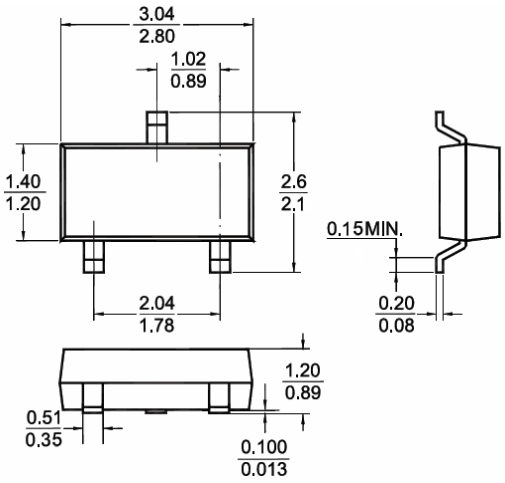
· As complementary types the NPN transistors MMBT3904 is recommended

· Suffix "H" indicates Halogen-free parts, ex. MMBT3906H



1. Base 2. Emitter 3. Collector

SOT-23



Dimensions in millimeter

Maximum Ratings(T_A =25 ℃ unless otherwise noted)

Parameter	Symbol	Value	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5.0	V
Collector Current	I_C	-200	mA
Total Device Dissipation FR– 5 Board(1) Derate above 25℃	P_D	225 1.8	mW mW / ℃
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	556	℃ / W
Total Device Dissipation Alumina Substrate(2) Derate above 25℃	P_D	300 2.4	mW mW / ℃
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	417	℃ / W
Junction and Storage Temperature Range	T_J, T_{stg}	-55 to +150	℃

(1) Device on FR–5 = 1.0 x 0.75 x 0.062 in.

(2) Device on alumina substrate = 0.4 x 0.3 x 0.024 in. 99.5% alumina.

Electrical Characteristics(T_A =25 ℃ unless otherwise specified)

Parameter	Conditions	Symbol	Min.	Max.	Unit
Collector-base breakdown voltage	I_C= -10μA, I_E= 0	$V_{(BR)CBO}$	-40	--	V
Collector-emitter breakdown voltage(3)	I_C= -1.0mA, I_B= 0	$V_{(BR)CEO}$	-40	--	V
Emitter-base breakdown voltage	I_E= -10μA, I_C= 0	$V_{(BR)EBO}$	-5.0	--	V
Base cut-off current	V_{CE}= -30V, V_{EB}= -3.0V	I_{BL}	--	-50	nA
Collector cut-off current	V_{CE}= -30V, V_{EB}= -3.0V	I_{CEX}	--	-50	nA
DC current gain	V_{CE}= -1.0V, I_C= -0.1mA	h_{FE}	60	--	--
	V_{CE}= -1.0V, I_C= -1.0mA		80	--	
	V_{CE}= -1.0V, I_C= -10mA		100	300	
	V_{CE}= -1.0V, I_C= -50mA		60	--	
	V_{CE}= -1.0V, I_C= -100mA		30	--	
Collector-emitter saturation voltage(3)	I_C= -10 mA, I_B= -1.0mA	$V_{CE(sat)}$	--	-0.25	V
	I_C= -50 mA, I_B= -5.0mA			-0.4	
Base-emitter saturation voltage(3)	I_C= -10 mA, I_B= -1.0mA	$V_{BE(sat)}$	-0.65	-0.85	V
	I_C= -50 mA, I_B= -5.0mA		--	-0.95	

(3) Pulse Test: Pulse Width <300 μs, Duty Cycle <2.0%.

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Electrical Characteristics(T_A =25 ℃ unless otherwise specified)

Parameter	Conditions	Symbol	Min.	Max.	Unit
Current–gain — bandwidth product	V_{CE}= -20V, I_C= -10mA, f=100MHz	f_T	250	--	MHz
Output capacitance	V_{CB}= -5.0V, I_E= 0, f = 1.0 MHz	C_{obo}	--	4.5	pF
Input capacitance	V_{BE}= -0.5V, I_C= 0, f= 1.0 MHz	C_{ibo}	--	10	pF
Input impedancen	V_{CE}= -10V, I_C= -1.0mA, f= 1.0 kHz	h_{ie}	2.0	12	kΩ
Voltage feedback Ratio	V_{CE}= -10V, I_C= -1.0mA, f= 1.0 kHz	h_{re}	0.1	10	$\times 10^{-4}$
Small–signal current gain	V_{CE}= -10V, I_C= -1.0mA, f= 1.0 kHz	h_{fe}	100	400	--
Output admittance	V_{CE}= -10V, I_C= -1.0mA, f= 1.0 kHz	h_{oe}	3.0	60	μmhos
Noise figure	V_{CE}= -5.0V, I_C= -100μA, R_S= 1.0k Ω, f= 1.0 kHz	NF	--	4.0	dB
Delay time	V_{CC}= -3.0V, V_{BE}= 0.5V	t_d	--	35	nS
Rise time	I_C= -10mA , I_{B1}= -1.0mA	t_r	--	35	nS
Storage time	V_{CC}= -3.0V, I_C= -10mA	t_s	--	225	nS
Fall time	I_{B1}= I_{B2}= -1.0mA	t_f	--	75	nS

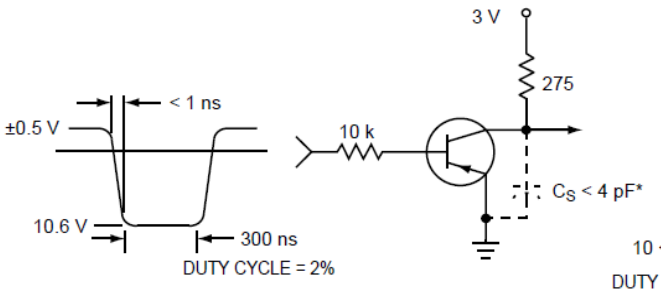

Figure 1. Delay and Rise Time Equivalent Test Circuit

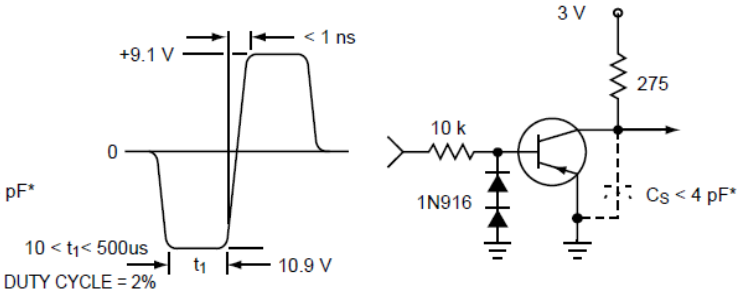

Figure 2. Storage and Fall Time Equivalent Test Circuit

* Total shunt capacitance of test jig and connectors

RATINGS AND CHARACTERISTIC CURVES

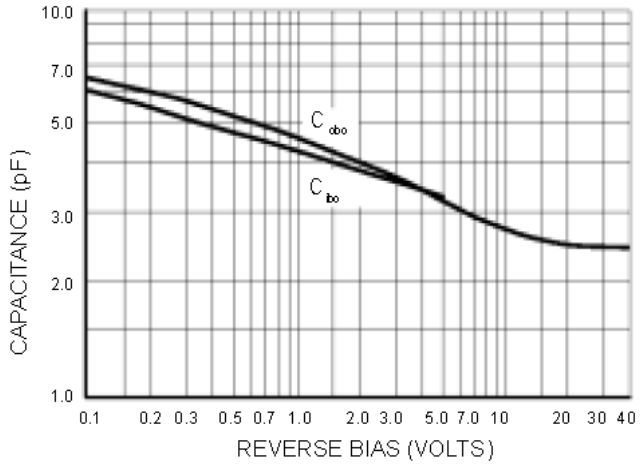

Figure 3. Capacitance

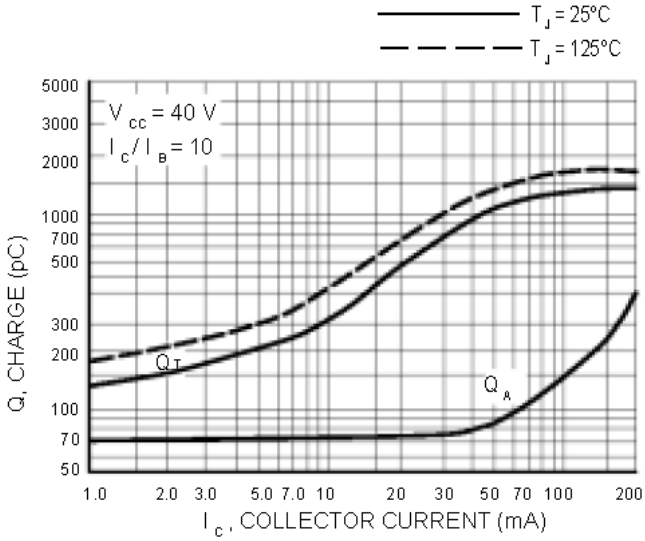

Figure 4. Charge Data

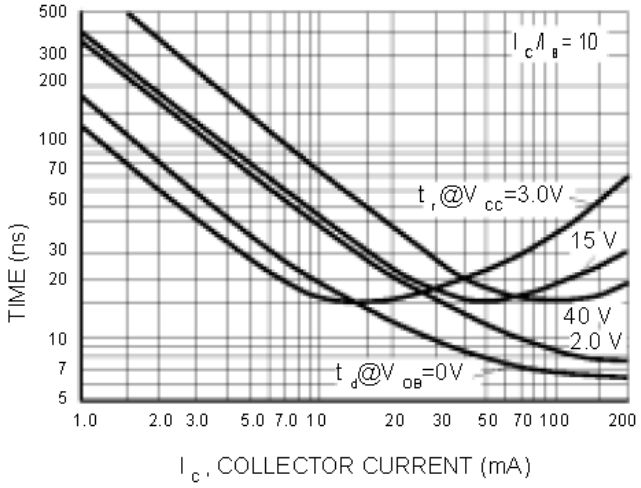

Figure 5. Turn–On Time

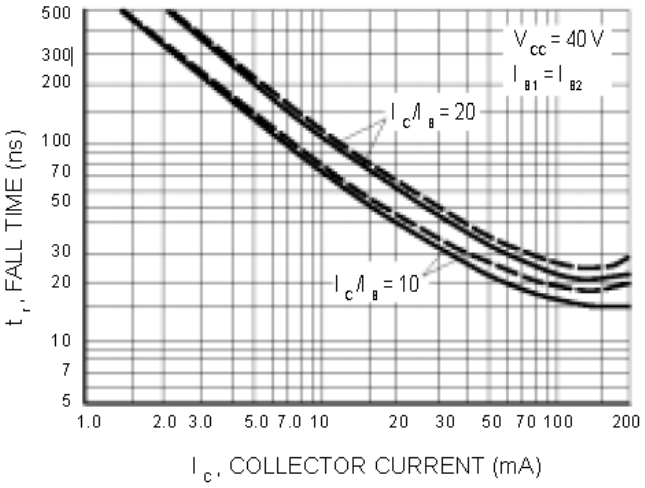

Figure 6. Fall Time

RATINGS AND CHARACTERISTIC CURVES

TYPICAL AUDIO SMALL–SIGNAL CHARACTERISTICS

NOISE FIGURE VARIATIONS

(V_{CE} = -5.0 V, T_A = 25°C, Bandwidth = 1.0 Hz)

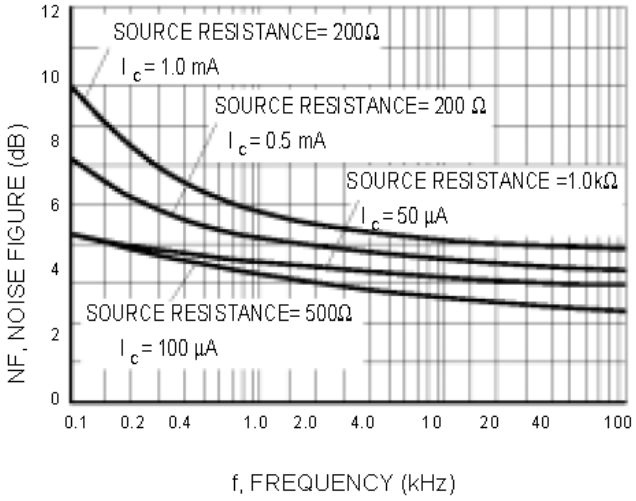

Figure 7. Noise Figure

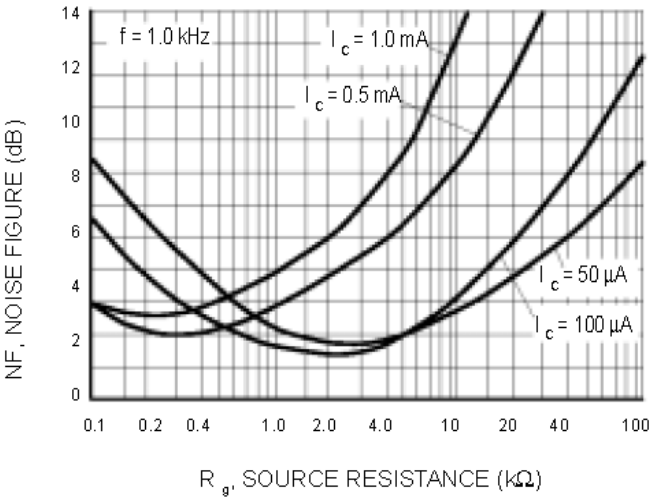

Figure 8. Noise Figure

h PARAMETERS

(V_{CE} = 10 V, f = 1.0 kHz, T_A = 25°C)

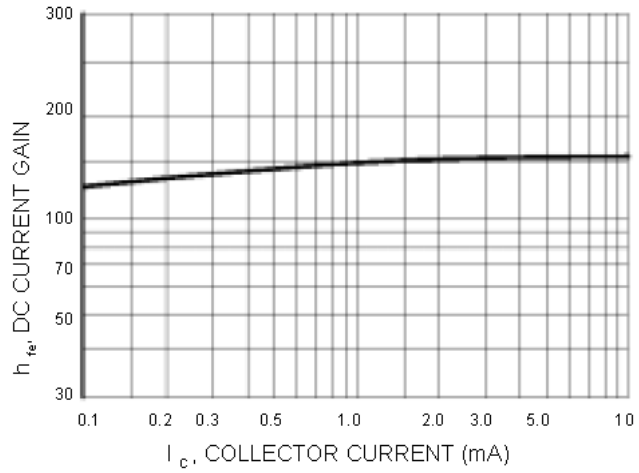

Figure 9. Current Gain

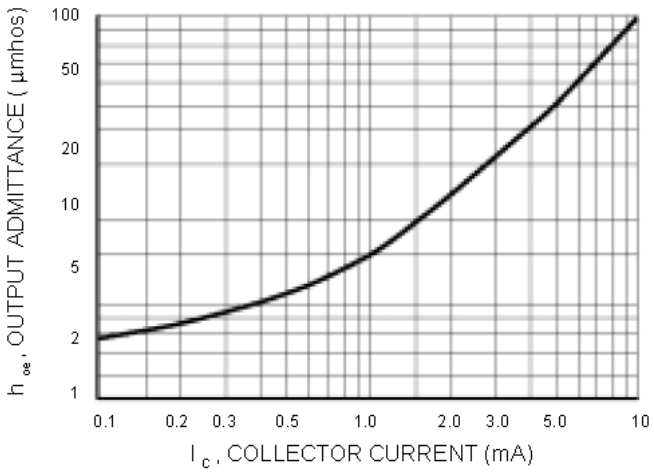

Figure 10. Output Admittance

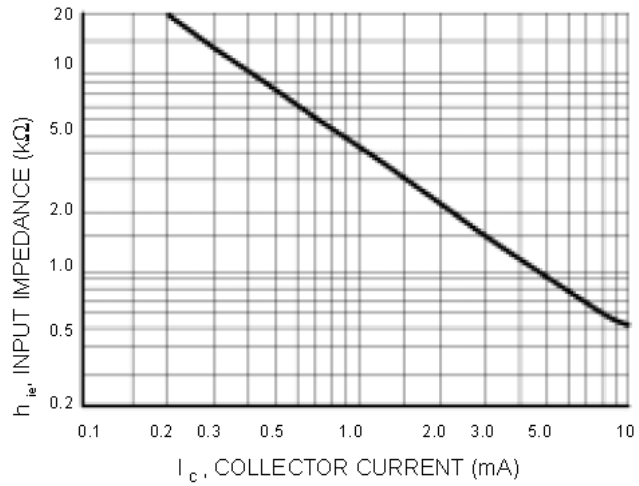

Figure 11. Input Impedance

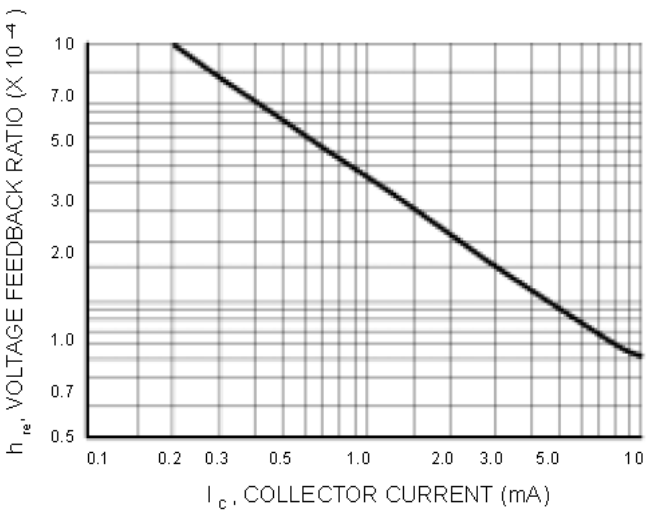

Figure 12. Voltage Feedback Ratio

RATINGS AND CHARACTERISTIC CURVES

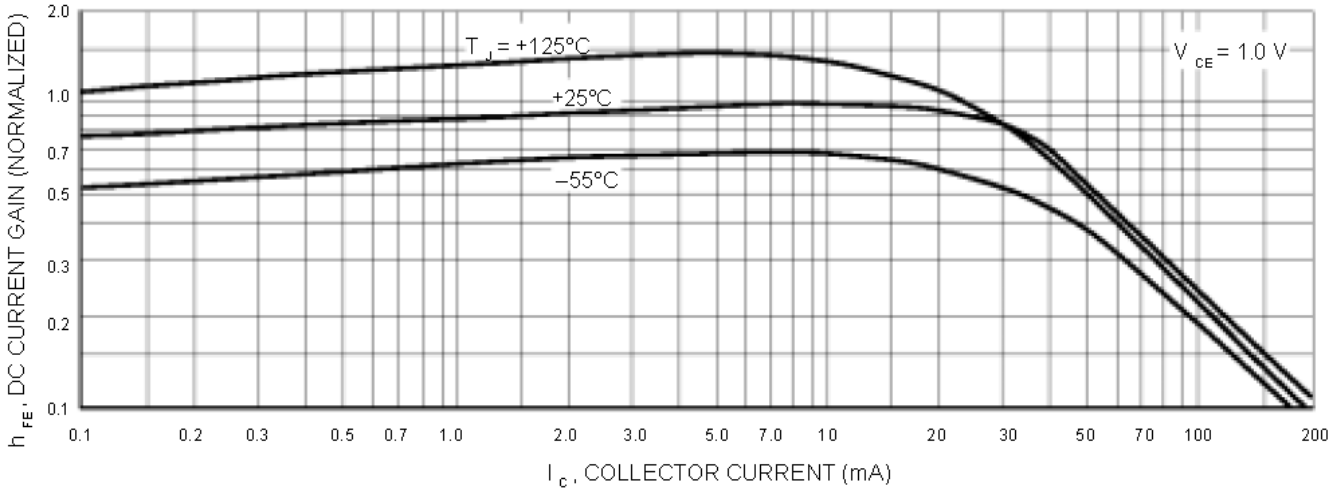

Figure 13. DC Current Gain

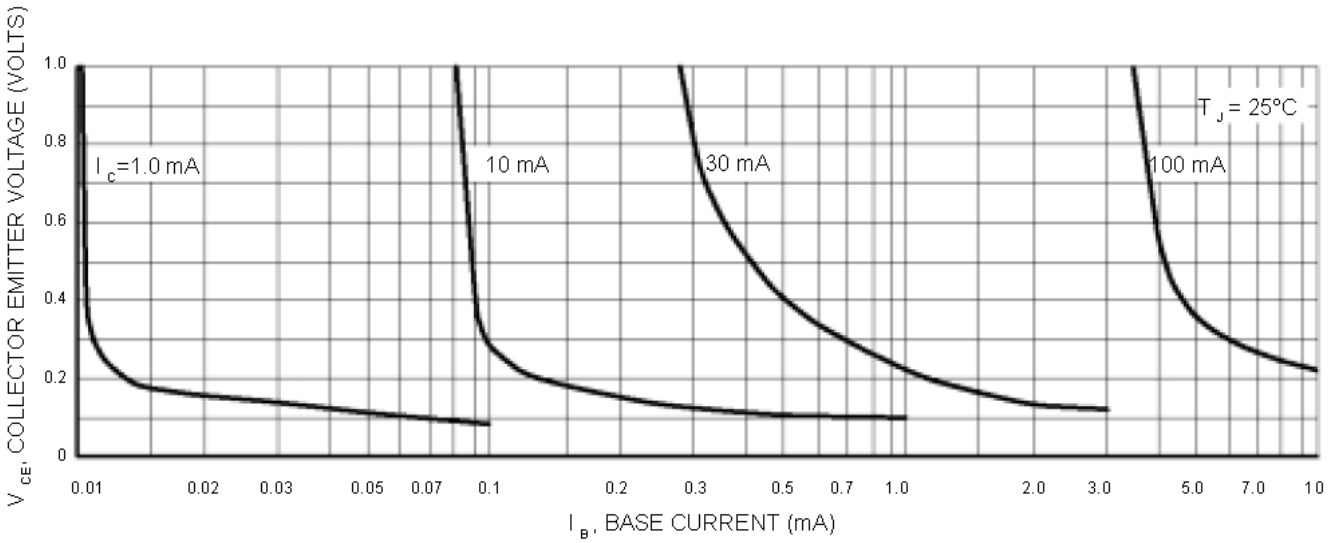

Figure 14. Collector Saturation Region

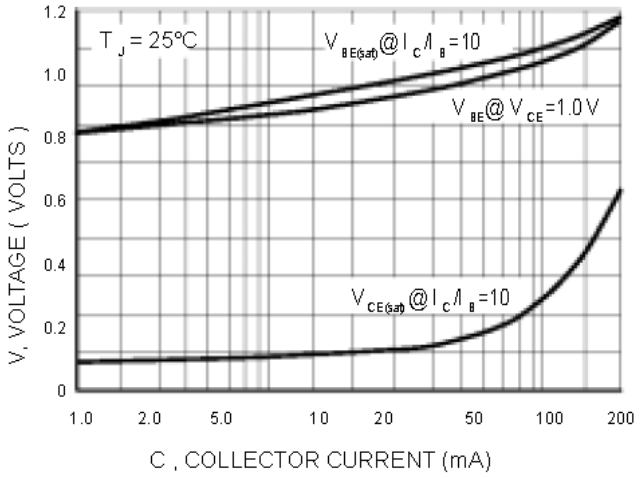

Figure 15. "ON" Voltages

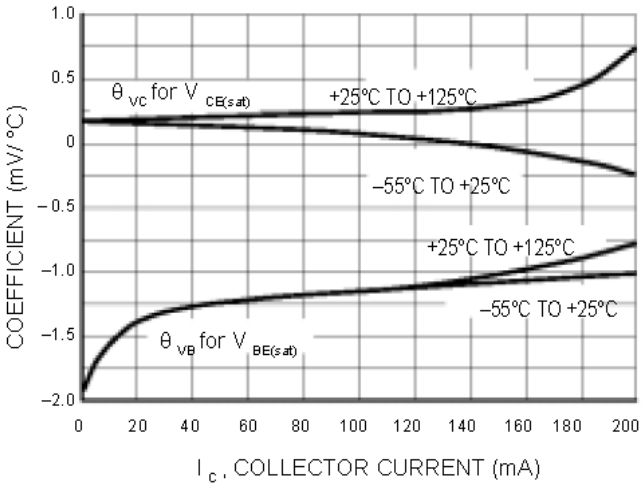

Figure 16. Temperature Coefficients